Electronic Supporting Information

Histidine-directed synthesis and optical properties of two indium phosphite-oxalates with three-dimensional structures[†]

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Synthesis

The starting material $In(OH)_3$, L-histidine, H_3PO_3 , and $H_2C_2O_4 \cdot 2H_2O$ were commercially available with analytical grade and used without further processing.

In₂(C₆H₁₀N₃O₂)(HPO₃)₂(C₂O₄)_{1.5}·0.5H₂O (**1**) was prepared by heating a mixture of In(OH)₃ (0.166 g, 1 mmol), L-histidine (0.155 g, 1 mmol), H₃PO₃ (0.082 g, 1 mmol), and H₂C₂O₄·2H₂O (0.378 g, 3 mmol) in a 25 mL Teflon-lined stainless steel autoclave at 150 °C for 10 days. After cooling to room temperature, plate crystals of compound **1** were separated from the resulting product by filtration, washed with distilled water, and dried in air (43% yield based on Indium).

 $(C_6H_{11}N_3O_2)$ ·[In₄($C_6H_{10}N_3O_2$)(HPO₃)₅(H₂PO₃)(C_2O_4)₂] (**2**) was prepared by heating a mixture of In(OH)₃ (0.166 g, 1 mmol), L-histidine (0.155 g, 1 mmol), H₃PO₃ (0.205 g, 2.5 mmol), and H₂C₂O₄·2H₂O (0.378 g, 3 mmol) in a 25 mL Teflon-lined stainless steel autoclave at 150 °C for 10 days. After cooling to room temperature, prismatic crystals of compound **2** were separated from the resulting product by filtration, washed with distilled water, and dried in air (48% yield based on Indium).

Single crystal X-ray diffraction

Single crystal X-ray diffraction data were collected on a Bruker APEX-II CCD diffractometer with Mo-K α radiation ($\lambda = 0.71073$ Å) at room temperature. The crystal structures were solved by direct methods. The structures were refined on F^2 by full-matrix least-squares methods using the SHELXTL program package.^{1,2}

Powder X-ray diffraction

Powder XRD data were obtained using a Shimazu XRD-6100 diffractometer with Cu-Ka radiation

($\lambda = 1.5418$ Å), in the angular range of $2\theta = 5-50^{\circ}$, and with a scan step width of 0.02° and a fixed time of 0.2 s.

IR spectroscopy

IR spectra of compounds 1 and 2 were obtained on a Nicolet Impact 410 FTIR spectrometer by using KBr pellets, with transmission mode from 4000 to 400 cm⁻¹.

UV-vis diffuse reflectance spectroscopy

The UV-vis diffuse reflectance spectra of the two compounds were recorded at room temperature on a Shimadzu UV-2600 UV-vis spectrophotometer in the wavelength range of 200-800 nm. BaSO₄

powder was used as 100% reflectance reference. The Kubelka-Munk function was used to calculate the absorption spectra from the reflection spectra: $F(R) = \alpha/S = (1-R)^2/2R$, where *R* is the reflectance, α is the absorption coefficient, and *S* is the scattering coefficient.^{3,4}

SHG tests

A Q-switched Nd:YAG laser was used to measure the SHG signals of the sieved samples under 1064 nm radiation based on Kurtz–Perry method.⁵

Birefringence measurement

The birefringences of compounds **1** and **2** were characterized by using the polarizing microscope equipped (ZEISS Axio Scope. A1) with a Berek compensator.

Luminescence performance measurement

The photoluminescence (PL) properties and PLQY of compounds **1** and **2** were characterized using an Edinburgh FS-5 fluorescence spectrometer with a calibrated integrating sphere system. The timeresolved PL decay was measured on a Fluoromax-3 fluorescence spectrometer.

Computational methods

In order to understand the relationship between structure and properties of the two compounds, the first-principles calculations were carried out by using the CASTEP.⁶ The generalized gradient approximation (GGA) with Perdew-Burke-Ernzerhof (PBE) was used for all the calculations.⁷ All the atoms were performed by Norm-conserving pseudopotentials (NCP), with H 1s, C $2s^22p^2$, N $2s^22p^3$, O $2s^22p^4$, P $3s^23p^3$, In $5s^25p^1$ treated as valence electrons.⁸ The kinetic energy cutoff of 750 eV and the k-point sampling of $4 \times 4 \times 3$ were chosen for compound **1** and the k-point sampling of $4 \times 1 \times 4$ were chosen for compound **2**.⁹ All other parameter settings are CASTEP default values.



Fig. S1 Experimental and simulated XRD patterns for compound 1.



Fig. S2 Experimental and simulated XRD patterns for compound 2.



Fig. S3 TGA analysis of compound 1 under N_2 atmosphere.



Fig. S4 TGA analysis of compound 2 under N_2 atmosphere.



Fig. S5 The IR spectrum of compound 1.



Fig. S6 The IR spectrum of compound 2.



Fig. S7 Tauc plot of $[F(R)hv]^2$ versus hv for the optical band gap of compound **1**.



Fig. S8 Tauc plot of $[F(R)hv]^2$ versus hv for the optical band gap of compound 2.



Fig. S9 The photoluminescence quantum yield (PLQY) diagram of compound 1.



Fig. S10 The photoluminescence quantum yield (PLQY) diagram of compound 2.



Fig. S11 Calculated band structure of compound 1 (the Fermi level is set at 0 eV).



Fig. S12 Calculated band structure of compound 2 (the Fermi level is set at 0 eV).



Fig. S13 Total and partial DOSs for compound 1.



Fig. S14 Total and partial DOSs for compound 2.



Fig. S15 Calculated dispersion of refractive index curves and birefringence of compound 1.



Fig. S16 Calculated dispersion of refractive index curves and birefringence of compound 2.

References

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